

# MOS INTEGRATED CIRCUIT $\mu$ PD441000L-X

# 1M-BIT CMOS STATIC RAM 128K-WORD BY 8-BIT EXTENDED TEMPERATURE OPERATION

#### **Description**

The  $\mu$ PD441000L-X is a high speed, low power, 1,048,576 bits (131,072 words by 8 bits) CMOS static RAM. The  $\mu$ PD441000L-X has two chip enable pins (/CE1, CE2) to extend the capacity.

★ The  $\mu$ PD441000L-X is packed in 32-pin plastic SOP and 32-pin plastic TSOP (I) (8×13.4 mm) and (8×20 mm).

#### **Features**

• 131,072 words by 8 bits organization

• Fast access time: 70, 85, 100, 120, 150 ns (MAX.)

• Low voltage operation

(B version: Vcc = 2.7 to 3.6 V, C version: Vcc = 2.2 to 3.6 V, D version: Vcc = 1.8 to 3.6 V)

• Low Vcc data retention

(B version: 2.0 V (MIN.), C version, D version: 1.5 V (MIN.))

• Operating ambient temperature :  $T_A = -25$  to +85 °C

• Output Enable input for easy application

• Two Chip Enable inputs: /CE1, CE2

Part number	Access time	Operating supply	Operating ambient		Supply current	
	ns (MAX.)	voltage	temperature	At operating	At standby	At data retention
		V	°C	mA (MAX.)	μA (MAX.)	μA (MAX.)
μPD441000L-BxxX	70, 85, 100	2.7 to 3.6	-25 to +85	25	2	2 Note
μPD441000L-CxxX	100, 120	2.2 to 3.6				
μPD441000L-DxxX	120, 150	1.8 to 3.6				

**Note** 0.5  $\mu$ A (TA  $\leq$  40 °C)

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Not all devices/types available in every country. Please check with local NEC representative for availability and additional information.



#### **★** Ordering Information

Part number	Package	Access time	Operating	Operating	Remark
		ns (MAX.)	supply voltage	temperature	
			V	°C	
μPD441000LGW-B70X	32-pin Plastic SOP	70	2.7 to 3.6	-25 to +85	B version
μPD441000LGW-B85X	(13.34 mm (525))	85			
μPD441000LGW-B10X		100			
μPD441000LGU-B70X-9JH	32-pin Plastic TSOP (I)	70			
μPD441000LGU-B85X-9JH	(8×13.4) (Normal bent)	85			
μPD441000LGU-B10X-9JH		100			
μPD441000LGU-B70X-9KH	32-pin Plastic TSOP (I)	70			
μPD441000LGU-B85X-9KH	(8×13.4) (Reverse bent)	85			
μPD441000LGU-B10X-9KH		100			
μPD441000LGZ-B70X-KJH	32-pin Plastic TSOP (I)	70			
μPD441000LGZ-B85X-KJH	(8×20) (Normal bent)	85			
μPD441000LGZ-B10X-KJH		100			
μPD441000LGZ-B70X-KKH	32-pin Plastic TSOP (I)	70			
μPD441000LGZ-B85X-KKH	(8×20) (Reverse bent)	85			
μPD441000LGZ-B10X-KKH		100			
μPD441000LGW-C10X	32-pin Plastic SOP	100	2.2 to 3.6		C version
μPD441000LGW-C12X	(13.34 mm (525))	120			
μPD441000LGU-C10X-9JH	32-pin Plastic TSOP (I)	100			
μPD441000LGU-C12X-9JH	(8×13.4) (Normal bent)	120			
μPD441000LGU-C10X-9KH	32-pin Plastic TSOP (I)	100			
μPD441000LGU-C12X-9KH	(8×13.4) (Reverse bent)	120			
μPD441000LGZ-C10X-KJH	32-pin Plastic TSOP (I)	100			
μPD441000LGZ-C12X-KJH	(8×20) (Normal bent)	120			
μPD441000LGZ-C10X-KKH	32-pin Plastic TSOP (I)	100			
μPD441000LGZ-C12X-KKH	(8×20) (Reverse bent)	120			
μPD441000LGW-D12X	32-pin Plastic SOP	120	1.8 to 3.6		D version
μPD441000LGW-D15X	(13.34 mm (525))	150			
μPD441000LGU-D12X-9JH	32-pin Plastic TSOP (I)	120			
μPD441000LGU-D15X-9JH	(8×13.4) (Normal bent)	150			
μPD441000LGU-D12X-9KH	32-pin Plastic TSOP (I)	120			
μPD441000LGU-D15X-9KH	(8×13.4) (Reverse bent)	150			
μPD441000LGZ-D12X-KJH	32-pin Plastic TSOP (I)	120			
μPD441000LGZ-D15X-KJH	(8×20) (Normal bent)	150			
μPD441000LGZ-D12X-KKH	32-pin Plastic TSOP (I)	120			
μPD441000LGZ-D15X-KKH	(8×20) (Reverse bent)	150			

#### Pin Configurations (Marking Side)

/xxx indicates active low signal.

32-pin Plastic SOP (13.34 mm (525))  $[ \mu PD441000LGW-BxxX ]$   $[ \mu PD441000LGW-CxxX ]$   $[ \mu PD441000LGW-DxxX ]$ 

1			
NC O-	1	32	——○ Vcc
A16 ○ →	2	31	<b>←</b> ○ A15
A14 ○	3	30	<b>-</b> ○ CE2
A12 ○ →	4	29	<b>←</b> —○ /WE
A7 ○	5	28	<b>←</b> ○ A13
A6 ○	6	27	<b>←</b> ○ A8
A5 ○	7	26	<b>←</b> ○ A9
A4 ○	8	25	<b>←</b> ○ A11
A3 ○ →	9	24	<b>←</b> ○ /OE
A2 ○	10	23	<b>←</b> ○ A10
A1 ○	11	22	<b>←</b> —○ /CE1
A0 ○ →	12	21	<b>←→</b> ○ I/O8
I/O1 ○ <del>&lt; →</del>	13	20	<b>←→</b> ○ I/O7
1/02 ○←→	14	19	<b></b> ○ I/O6
I/O3 ○ <del></del>	15	18	<b>←→</b> ○ I/O5
GND O-	16	17	<b>←→</b> ○ I/O4

A0 - A16 : Address inputs

I/O1 - I/O8 : Data inputs / outputs
/CE1, CE2 : Chip Enable 1, 2
/WE : Write Enable
/OE : Output Enable
Vcc : Power supply

GND : Ground

NC : No connection

**Remark** Refer to **Package Drawings** for the 1-pin index mark.

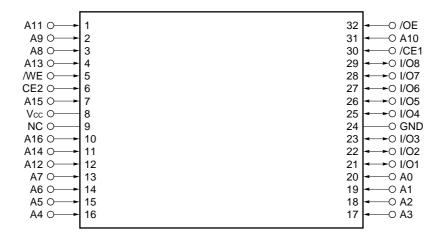
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#### 32-pin Plastic TSOP (I) (8×13.4) (Normal bent)

[ μPD441000LGU-BxxX-9JH ]
[ μPD441000LGU-CxxX-9JH ]
[ μPD441000LGU-DxxX-9JH ]

#### 32-pin Plastic TSOP (I) (8×20) (Normal bent)

[  $\mu$ PD441000LGZ-BxxX-KJH ] [  $\mu$ PD441000LGZ-CxxX-KJH ] [  $\mu$ PD441000LGZ-DxxX-KJH ]



A0 - A16 : Address inputs

I/O1 - I/O8 : Data inputs / outputs

/CE1, CE2 : Chip Enable 1, 2

/WE : Write Enable

/OE : Output Enable

Vcc : Power supply

GND : Ground

NC : No connection

**Remark** Refer to **Package Drawings** for the 1-pin index mark.

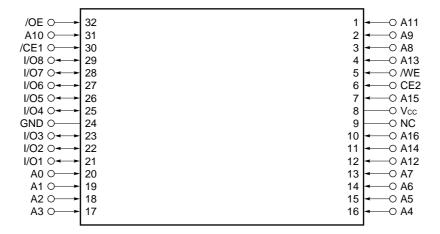
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#### 32-pin Plastic TSOP (I) (8×13.4) (Reverse bent)

[  $\mu$ PD441000LGU-BxxX-9KH ] [  $\mu$ PD441000LGU-CxxX-9KH ] [  $\mu$ PD441000LGU-DxxX-9KH ]

#### 32-pin Plastic TSOP (I) (8×20) (Reverse bent)

[ μPD441000LGZ-BxxX-KKH ]
[ μPD441000LGZ-CxxX-KKH ]
[ μPD441000LGZ-DxxX-KKH ]



A0 - A16 : Address inputs

I/O1 - I/O8 : Data inputs / outputs

/CE1, CE2 : Chip Enable 1, 2

/WE : Write Enable

/OE : Output Enable

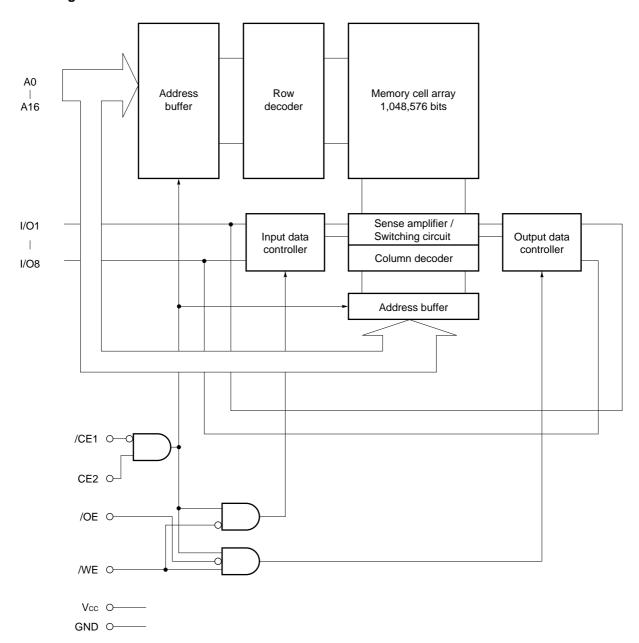
Vcc : Power supply
GND : Ground

NC : No connection

**Remark** Refer to **Package Drawings** for the 1-pin index mark.

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#### **Block Diagram**



#### **Truth Table**

/CE1	CE2	/OE	/WE	Mode	I/O	Supply current
Н	×	×	×	Not selected	High impedance	Isb
×	L	×	×	Not selected	High impedance	
L	Н	Н	Н	Output disable	High impedance	ICCA
L	Н	L	Н	Read	<b>D</b> оит	
L	Н	×	L	Write	Din	

 $\textbf{Remark} \hspace{0.1in} \times \hspace{0.1in} : \hspace{0.1in} V \hspace{0.1in} \text{ih or } V \hspace{0.1in} \text{i.}$ 



#### **Electrical Specifications**

#### **Absolute Maximum Ratings**

Parameter	Symbol	Condition	Rating	Unit
Supply voltage	Vcc		-0.5 Note to +4.6	٧
Input / Output voltage	VT		−0.5 Note to Vcc+0.5	V
Operating ambient temperature	TA		-25 to +85	°C
Storage temperature	Tstg		-55 to +125	°C

Note -3.0 V (MIN.) (Pulse width: 30 ns)

Caution Exposing the device to stress above those listed in Absolute Maximum Rating could cause permanent damage. The device is not meant to be operated under conditions outside the limits described in the operational section of this specification. Exposure to Absolute Maximum Rating conditions for extended periods may affect device reliability.

#### **Recommended Operating Conditions**

Parameter	Symbol	Condition	μPD4410	μPD441000L-BxxX		μPD441000L-CxxX		μPD441000L-DxxX		
			MIN.	MAX.	MIN.	MAX.	MIN.	MAX.		
Supply voltage	Vcc		2.7	3.6	2.2	3.6	1.8	3.6	V	
High level input voltage	VIH	2.7 V ≤ Vcc ≤ 3.6 V	2.4	Vcc+0.5	2.4	Vcc+0.5	2.4	Vcc+0.5	V	
		2.2 V ≤ Vcc < 2.7 V	-	-	2.0	Vcc+0.5	2.0	Vcc+0.5		
		1.8 V ≤ Vcc < 2.2 V				_	1.6	Vcc+0.5		
Low level input voltage	VIL		-0.3 Note	+0.5	-0.3 Note	+0.3	-0.3 Note	+0.2	V	
Operating ambient temperature	TA		-25	+85	-25	+85	-25	+85	°C	

Note -3.0 V (MIN.) (Pulse width: 30 ns)

#### Capacitance ( $T_A = 25$ °C, f = 1 MHz)

Parameter	Symbol	Test condition	MIN.	TYP.	MAX.	Unit
Input capacitance	Cin	Vin = 0 V			6	pF
Input / Output capacitance	C <sub>I/O</sub>	V <sub>1</sub> /O = 0 V			10	pF

Remarks 1. VIN: Input voltage

Vi/o: Input / Output voltage

2. These parameters are periodically sampled and not 100% tested.

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#### **DC Characteristics (Recommended Operating Conditions Unless Otherwise Noted)**

Parameter	Symbol	Test condit	ion	μPD4	41000L	-BxxX	μPD4	41000L	-CxxX	μPD4	41000L	-DxxX	Unit
				MIN.	TYP.	MAX.	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.	
Input leakage current	lu	V <sub>IN</sub> = 0 V to V <sub>CC</sub>	V <sub>IN</sub> = 0 V to V <sub>CC</sub>			+1.0	-1.0		+1.0	-1.0		+1.0	μА
I/O leakage	ILO	$V_{I/O} = 0 \text{ V to Vcc, /CE}$	1 = Vін or	-1.0		+1.0	-1.0		+1.0	-1.0		+1.0	μΑ
current		CE2 = VIL or /WE = VI	L or /OE = VIH										
Operating	ICCA1	/CE1 = VIL, CE2 = VIH	,		23	25		23	25		23	25	mA
supply current		Minimum cycle time,	Vcc ≤ 2.7 V		_	_		20	23		20	23	
		I <sub>1/0</sub> = 0 mA	Vcc ≤ 2.2 V		_	_		_	_		17	20	
	ICCA2	/CE1 = VIL, CE2 = VIH	,			5			5			5	
		I <sub>1/O</sub> = 0 mA	Vcc ≤ 2.7 V			_			4			4	
			Vcc ≤ 2.2 V			_			_			3	
	Іссаз	/CE1 ≤ 0.2 V, CE2 ≥ V	/cc − 0.2 V,			4			4			4	
		Cycle = 1 MHz, I <sub>I/O</sub> = 0	0 mA,										
		$V_{IL} \leq 0.2 \ V,$	Vcc ≤ 2.7 V			_			3			3	
		$V_{\text{IH}} \geq V_{\text{CC}} - 0.2 \; V$	Vcc ≤ 2.2 V			_			_			3	
Standby	IsB	/CE1 = V <sub>IH</sub> or CE2 = \	/ <sub>IL</sub>			0.3			0.3			0.3	mA
supply current	I <sub>SB1</sub>	$/CE1 \ge Vcc - 0.2 V$ ,			0.05	2		0.05	2		0.05	2	μΑ
		CE2 ≥ Vcc - 0.2 V	Vcc ≤ 2.7 V		_	_		0.04	2		0.04	2	
			Vcc ≤ 2.2 V		_	_		_	_		0.03	1.5	
	I <sub>SB2</sub>	CE2 ≤ 0.2 V			0.05	2		0.05	2		0.05	2	
			Vcc ≤ 2.7 V		_	_		0.04	2		0.04	2	
			Vcc ≤ 2.2 V		_	_		_	_		0.03	1.5	
High level	Vон	Iон = -0.5 mA		2.4			2.4			2.4			V
output voltage			Vcc ≤ 2.7 V	-			1.8			1.8			
			Vcc ≤ 2.2 V	_			_			1.5			
Low level	Vol	IoL = 1.0 mA				0.4			0.4			0.4	٧
output voltage													

Remarks 1. VIN: Input voltage

Vi/o: Input / Output voltage

2. These DC characteristics are in common regardless of package types and access time.

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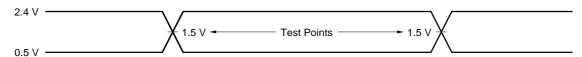


#### **AC Characteristics (Recommended Operating Conditions Unless Otherwise Noted)**

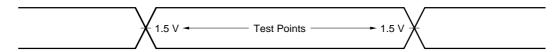
#### **AC Test Conditions**

#### [ $\mu$ PD441000L-B70X, $\mu$ PD441000L-B85X, $\mu$ PD441000L-B10X ]

Input Waveform (Rise and Fall Time ≤ 5 ns)



#### **Output Waveform**

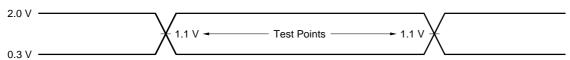


#### **Output Load**

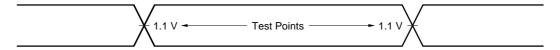
1TTL + 50 pF

#### [ $\mu$ PD441000L-C10X, $\mu$ PD441000L-C12X ]

Input Waveform (Rise and Fall Time ≤ 5 ns)



#### **Output Waveform**

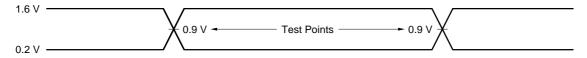


#### **Output Load**

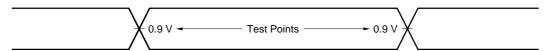
1TTL + 30 pF

#### [ $\mu$ PD441000L-D12X, $\mu$ PD441000L-D15X ]

Input Waveform (Rise and Fall Time ≤ 5 ns)



#### **Output Waveform**



#### **Output Load**

1TTL + 30 pF

#### Read Cycle (1/3) (B version)

Parameter	Symbol	μPD4410	00L-B70X	μPD4410	00L-B85X	μPD4410	00L-B10X	Unit	Condition
		MIN.	MAX.	MIN.	MAX.	MIN.	MAX.		
Read cycle time	trc	70		85		100		ns	
Address access time	<b>t</b> AA		70		85		100	ns	Note 1
/CE1 access time	<b>t</b> co1		70		85		100	ns	
CE2 access time	tco2		70		85		100	ns	
/OE to output valid	toe		35		45		50	ns	
Output hold from address change	tон	10		10		10		ns	
/CE1 to output in low impedance	<b>t</b> LZ1	10		10		10		ns	Note 2
CE2 to output in low impedance	tLZ2	10		10		10		ns	
/OE to output in low impedance	tolz	5		5		5		ns	
/CE1 to output in high impedance	t <sub>HZ1</sub>		25		30		35	ns	
CE2 to output in high impedance	t <sub>HZ2</sub>		25		30		35	ns	
/OE to output in high impedance	tонz		25		30		35	ns	

**Notes 1.** The output load is 1TTL + 50 pF.

2. The output load is 1TTL + 5 pF.

Remark These AC characteristics are in common regardless of package types.

#### Read Cycle (2/3) (C version)

Parameter	Symbol	μPD4410	00L-C10X	μPD4410	00L-C12X	Unit	Condition
		MIN.	MAX.	MIN.	MAX.		
Read cycle time	trc	100		120		ns	
Address access time	taa		100		120	ns	Note 1
/CE1 access time	<b>t</b> co1		100		120	ns	
CE2 access time	tco2		100		120	ns	
/OE to output valid	toe		50		60	ns	
Output hold from address change	tон	10		10		ns	
/CE1 to output in low impedance	t <sub>LZ1</sub>	10		10		ns	Note 2
CE2 to output in low impedance	t <sub>LZ2</sub>	10		10		ns	
/OE to output in low impedance	tolz	5		5		ns	
/CE1 to output in high impedance	<b>t</b> HZ1		35		40	ns	
CE2 to output in high impedance	<b>t</b> HZ2		35		40	ns	1
/OE to output in high impedance	tонz		35		40	ns	1

**Notes 1.** The output load is 1TTL + 30 pF.

2. The output load is 1TTL + 5 pF.

**Remark** These AC characteristics are in common regardless of package types.



#### Read Cycle (3/3) (D version)

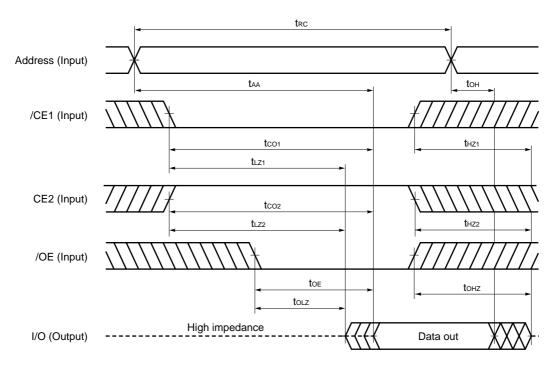
Parameter	Symbol	μPD4410	00L-D12X	μPD4410	00L-D15X	Unit	Condition
		MIN.	MAX.	MIN.	MAX.		
Read cycle time	trc	120		150		ns	
Address access time	taa		120		150	ns	Note 1
/CE1 access time	<b>t</b> co1		120		150	ns	
CE2 access time	tco2		120		150	ns	
/OE to output valid	toe		60		70	ns	
Output hold from address change	tон	10		10		ns	
/CE1 to output in low impedance	t <sub>LZ1</sub>	10		10		ns	Note 2
CE2 to output in low impedance	t <sub>LZ2</sub>	10		10		ns	
/OE to output in low impedance	tolz	5		5		ns	
/CE1 to output in high impedance	<b>t</b> HZ1		40		50	ns	
CE2 to output in high impedance	tHZ2		40		50	ns	
/OE to output in high impedance	tонz		40		50	ns	]

**Notes 1.** The output load is 1TTL + 30 pF.

2. The output load is 1TTL + 5 pF.

Remark These AC characteristics are in common regardless of package types.

#### **Read Cycle Timing Chart**



**Remark** In read cycle, /WE should be fixed to high level.

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#### Write Cycle (1/3) (B version)

Parameter	Symbol	μPD4410	00L-B70X	μPD4410	00L-B85X	μPD4410	00L-B10X	Unit	Condition
		MIN.	MAX.	MIN.	MAX.	MIN.	MAX.		
Write cycle time	twc	70		85		100		ns	
/CE1 to end of write	tcw1	55		70		80		ns	
CE2 to end of write	tcw2	55		70		80		ns	
Address valid to end of write	taw	55		70		80		ns	
Address setup time	<b>t</b> AS	0		0		0		ns	
Write pulse width	twp	50		60		60		ns	
Write recovery time	twr	0		0		0		ns	
Data valid to end of write	tow	35		35		40		ns	
Data hold time	tон	0		0		0		ns	
/WE to output in high impedance	<b>t</b> wnz		25		30		35	ns	Note
Output active from end of write	tow	5		5		5		ns	

**Note** The output load is 1TTL + 5 pF.

**Remark** These AC characteristics are in common regardless of package types.

#### Write Cycle (2/3) (C version)

Parameter	Symbol	μPD441000L-C10X		μPD4410	Unit	Condition	
		MIN.	MAX.	MIN.	MAX.		
Write cycle time	twc	100		120		ns	
/CE1 to end of write	tcw1	80		100		ns	
CE2 to end of write	tcw2	80		100		ns	
Address valid to end of write	taw	80		100		ns	
Address setup time	tas	0		0		ns	
Write pulse width	twp	60		85		ns	
Write recovery time	twr	0		0		ns	
Data valid to end of write	tow	45		60		ns	
Data hold time	<b>t</b> DH	0		0		ns	
/WE to output in high impedance	twnz		35		40	ns	Note
Output active from end of write	tow	5		5		ns	

**Note** The output load is 1TTL + 5 pF.

Remark These AC characteristics are in common regardless of package types.



#### Write Cycle (3/3) (D version)

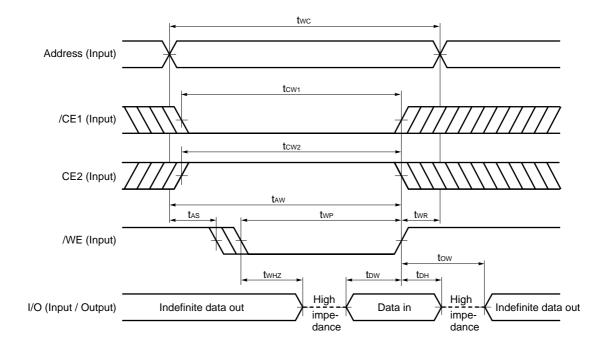
Parameter	Symbol	μPD4410	00L-D12X	μPD4410	00L-D15X	Unit	Condition
		MIN.	MAX.	MIN.	MAX.		
Write cycle time	twc	120		150		ns	
/CE1 to end of write	tcw1	100		120		ns	
CE2 to end of write	tcw2	100		120		ns	
Address valid to end of write	taw	100		120		ns	
Address setup time	tas	0		0		ns	
Write pulse width	twp	85		100		ns	
Write recovery time	twr	0		0		ns	
Data valid to end of write	tow	60		80		ns	
Data hold time	tон	0		0		ns	
/WE to output in high impedance	twnz		40		50	ns	Note
Output active from end of write	tow	5		5		ns	

**Note** The output load is 1TTL + 5 pF.

**Remark** These AC characteristics are in common regardless of package types.

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#### Write Cycle Timing Chart 1 (/WE Controlled)



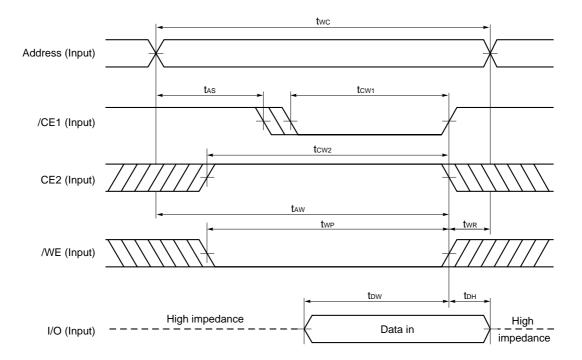
Cautions 1. During address transition, at least one of pins /CE1, CE2, /WE should be inactivated.

2. When I/O pins are in the output state, do not apply to the I/O pins signals that are opposite in phase with output signals.

Remarks 1. Write operation is done during the overlap time of a low level /CE1, /WE, and a high level CE2.

- 2. If /CE1 changes to low level at the same time or after the change of /WE to low level, or if CE2 changes to high level at the same time or after the change of /WE to low level, the I/O pins will remain high impedance state.
- 3. When /WE is at low level, the I/O pins are always high impedance. When /WE is at high level, read operation is executed. Therefore /OE should be at high level to make the I/O pins high impedance.

#### Write Cycle Timing Chart 2 (/CE1 Controlled)



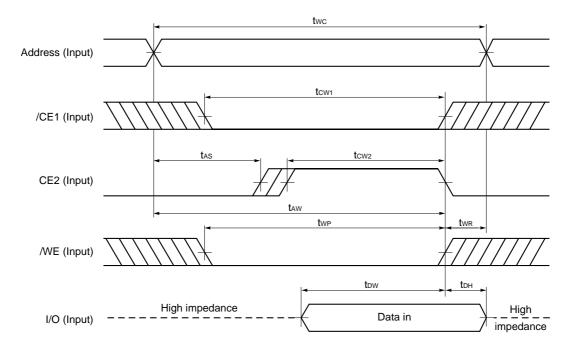
Cautions 1. During address transition, at least one of pins /CE1, CE2, /WE should be inactivated.

2. When I/O pins are in the output state, do not apply to the I/O pins signals that are opposite in phase with output signals.

Remark Write operation is done during the overlap time of a low level /CE1, /WE, and a high level CE2.

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#### Write Cycle Timing Chart 3 (CE2 Controlled)



Cautions 1. During address transition, at least one of pins /CE1, CE2, /WE should be inactivated.

2. When I/O pins are in the output state, do not apply to the I/O pins signals that are opposite in phase with output signals.

Remark Write operation is done during the overlap time of a low level /CE1, /WE, and a high level CE2.



### Low Vcc Data Retention Characteristics ( $T_A = -25 \text{ to } +85 \text{ }^{\circ}\text{C}$ )

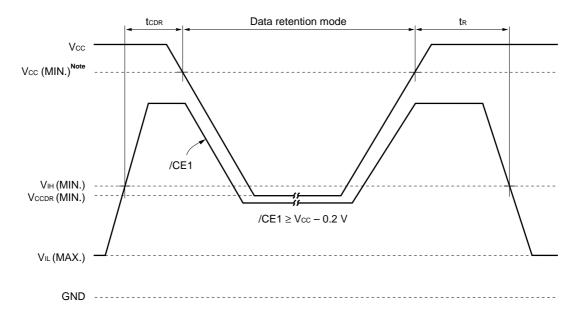
Parameter	Symbol	Test Condition	μPI	μPD441000L -BxxX		μPD441000L -CxxX		μPD441000L -DxxX			Unit	
			MIN.	TYP.	MAX.	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.	
Data retention supply voltage	Vccdr1	/CE1 ≥ Vcc - 0.2 V, CE2 ≥ Vcc - 0.2 V	2		3.6	1.5		3.6	1.5		3.6	V
	Vccdr2	CE2 ≤ 0.2 V	2		3.6	1.5		3.6	1.5		3.6	
Data retention supply current	ICCDR1	$Vcc = 3.0 \text{ V}, /CE1 \ge Vcc - 0.2 \text{ V},$ $CE2 \ge Vcc - 0.2 \text{ V} \text{ or } CE2 \le 0.2 \text{ V}$		0.05	2 Note		0.05	2 Note		0.05	2 Note	μΑ
	ICCDR2	Vcc = 3.0 V, CE2 ≤ 0.2 V		0.05	2 Note		0.05	2 Note		0.05	2 Note	
Chip deselection to data retention mode	tcdr		0			0			0			ns
Operation recovery time	ṫ̀R		5			5			5			ms

**Note** 0.5  $\mu$ A (TA  $\leq$  40 °C)

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#### **Data Retention Timing Chart**

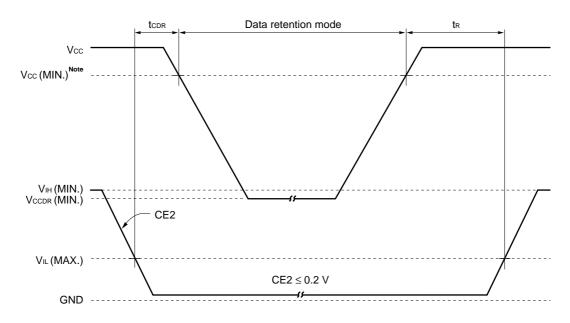
#### (1) /CE1 Controlled



Note B version: 2.7 V, C version: 2.2 V, D version: 1.8 V

**Remark** On the data retention mode by controlling /CE1, the input level of CE2 must be  $\geq$  Vcc - 0.2 V or  $\leq$  0.2 V. The other pins (Address, I/O, /WE, /OE) can be in high impedance state.

#### (2) CE2 Controlled



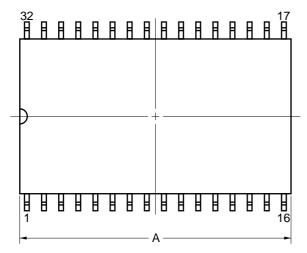
Note B version: 2.7 V, C version: 2.2 V, D version: 1.8 V

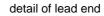
**Remark** On the data retention mode by controlling CE2, the other pins (/CE1, Address, I/O, /WE, /OE) can be in high impedance state.

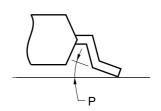


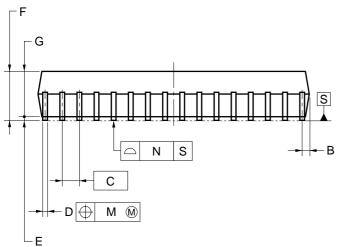
#### **Package Drawings**

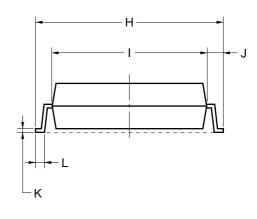
# \* 32-PIN PLASTIC SOP (13.34 mm (525))











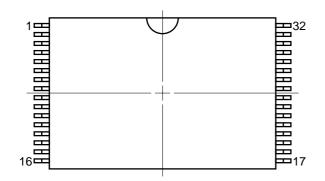
#### NOTE

Each lead centerline is located within 0.12 mm of its true position (T.P.) at maximum material condition.

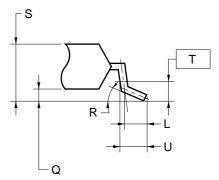
ITEM	MILLIMETERS
Α	20.61 MAX.
В	0.78 MAX.
С	1.27 (T.P.)
D	$0.40^{+0.10}_{-0.05}$
Е	0.15±0.05
F	2.95 MAX.
G	2.7
Н	14.1±0.3
I	11.3
J	1.4±0.2
K	$0.20^{+0.10}_{-0.05}$
L	0.8±0.2
М	0.12
N	0.10
Р	3°+7° -3°

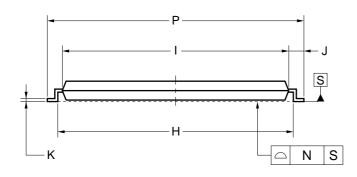
P32GW-50-525A-1

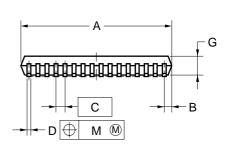
# \* 32-PIN PLASTIC TSOP(I) (8x13.4)



detail of lead end





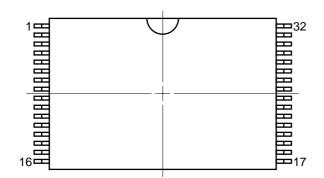


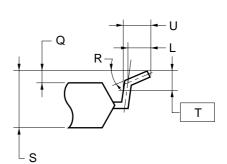
- Each lead centerline is located within 0.08 mm of its true position (T.P.) at maximum material condition.
- 2. "A" excludes mold flash. (Includes mold flash : 8.3 mm MAX.)

MILLIMETERS
8.0±0.1
0.45 MAX.
0.5 (T.P.)
0.22±0.05
1.0±0.05
12.4±0.2
11.8±0.1
0.8±0.2
$0.145^{+0.025}_{-0.015}$
0.5
0.08
0.08
13.4±0.2
0.1±0.05
3°+5°
1.2 MAX.
0.25
0.6±0.15

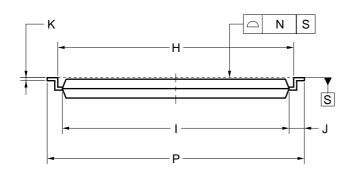
P32GU-50-9JH-2

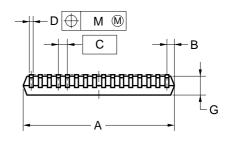
# \* 32-PIN PLASTIC TSOP(I) (8x13.4)





detail of lead end



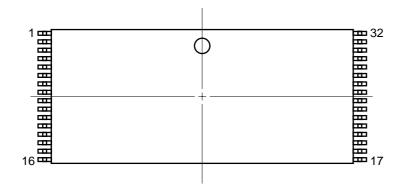


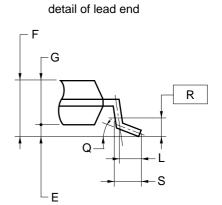
- Each lead centerline is located within 0.08 mm of its true position (T.P.) at maximum material condition.
- 2. "A" excludes mold flash. (Includes mold flash : 8.3 mm MAX.)

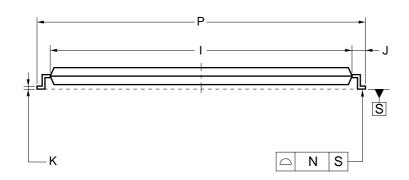
MILLIMETERS
8.0±0.1
0.45 MAX.
0.5 (T.P.)
0.22±0.05
1.0±0.05
12.4±0.2
11.8±0.1
0.8±0.2
$0.145^{+0.025}_{-0.015}$
0.5
0.08
0.08
13.4±0.2
0.1±0.05
3°+5° -3°
1.2 MAX.
0.25
0.6±0.15

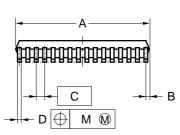
P32GU-50-9KH-2

# \* 32-PIN PLASTIC TSOP(I) (8x20)







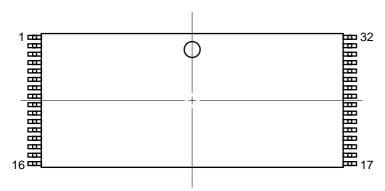


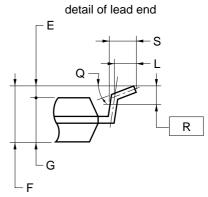
- Each lead centerline is located within 0.10 mm of its true position (T.P.) at maximum material condition.
- 2. "A" excludes mold flash. (Includes mold flash: 8.3 mm MAX.)

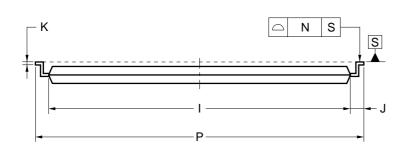
ITEM	MILLIMETERS
Α	8.0±0.1
В	0.45 MAX.
С	0.5 (T.P.)
D	0.22±0.05
Е	0.1±0.05
F	1.2 MAX.
G	0.97±0.08
I	18.4±0.1
J	0.8±0.2
K	0.145±0.05
L	0.5
М	0.10
N	0.10
Р	20.0±0.2
Q	3°+5°
R	0.25
S	0.60±0.15

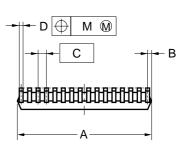
S32GZ-50-KJH1-2

# \* 32-PIN PLASTIC TSOP(I) (8x20)









- Each lead centerline is located within 0.10 mm of its true position (T.P.) at maximum material condition.
- 2. "A" excludes mold flash. (Includes mold flash: 8.3 mm MAX.)

ITEM	MILLIMETERS
Α	8.0±0.1
В	0.45 MAX.
С	0.5 (T.P.)
D	0.22±0.05
Е	0.1±0.05
F	1.2 MAX.
G	0.97±0.08
I	18.4±0.1
J	0.8±0.2
K	0.145±0.05
L	0.5
М	0.10
N	0.10
Р	20.0±0.2
Q	3°+5°
R	0.25
S	0.60±0.15

S32GZ-50-KKH1-2



#### **Recommended Soldering Conditions**

Please consult with our sales offices for soldering conditions of the  $\mu$ PD441000L-X.

#### **★** Types of Surface Mount Device

 $\mu$ PD441000LGW-BxxX : 32-pin Plastic SOP (13.34 mm (525)) μPD441000LGW-CxxX : 32-pin Plastic SOP (13.34 mm (525))  $\mu$ PD441000LGW-DxxX : 32-pin Plastic SOP (13.34 mm (525)) μPD441000LGU-BxxX-9JH : 32-pin Plastic TSOP (I) (8×13.4) (Normal bent)  $\mu$ PD441000LGU-CxxX-9JH : 32-pin Plastic TSOP (I) (8×13.4) (Normal bent) μPD441000LGU-DxxX-9JH : 32-pin Plastic TSOP (I) (8×13.4) (Normal bent) μPD441000LGU-BxxX-9KH : 32-pin Plastic TSOP (I) (8×13.4) (Reverse bent) μPD441000LGU-CxxX-9KH : 32-pin Plastic TSOP (I) (8×13.4) (Reverse bent)  $\mu$ PD441000LGU-DxxX-9KH : 32-pin Plastic TSOP (I) (8×13.4) (Reverse bent) μPD441000LGZ-BxxX-KJH : 32-pin Plastic TSOP (I) (8×20) (Normal bent) μPD441000LGZ-CxxX-KJH : 32-pin Plastic TSOP (I) (8×20) (Normal bent)

 $\mu$ PD441000LGZ-DxxX-KJH : 32-pin Plastic TSOP (I) (8×20) (Normal bent)  $\mu$ PD441000LGZ-BxxX-KKH : 32-pin Plastic TSOP (I) (8×20) (Reverse bent)  $\mu$ PD441000LGZ-CxxX-KKH : 32-pin Plastic TSOP (I) (8×20) (Reverse bent)  $\mu$ PD441000LGZ-DxxX-KKH : 32-pin Plastic TSOP (I) (8×20) (Reverse bent) NEC  $\mu$ PD441000L-X

[ MEMO ]

NEC  $\mu$ PD441000L-X

[ MEMO ]

#### NOTES FOR CMOS DEVICES

#### (1) PRECAUTION AGAINST ESD FOR SEMICONDUCTORS

Note:

Strong electric field, when exposed to a MOS device, can cause destruction of the gate oxide and ultimately degrade the device operation. Steps must be taken to stop generation of static electricity as much as possible, and quickly dissipate it once, when it has occurred. Environmental control must be adequate. When it is dry, humidifier should be used. It is recommended to avoid using insulators that easily build static electricity. Semiconductor devices must be stored and transported in an anti-static container, static shielding bag or conductive material. All test and measurement tools including work bench and floor should be grounded. The operator should be grounded using wrist strap. Semiconductor devices must not be touched with bare hands. Similar precautions need to be taken for PW boards with semiconductor devices on it.

#### (2) HANDLING OF UNUSED INPUT PINS FOR CMOS

Note:

No connection for CMOS device inputs can be cause of malfunction. If no connection is provided to the input pins, it is possible that an internal input level may be generated due to noise, etc., hence causing malfunction. CMOS devices behave differently than Bipolar or NMOS devices. Input levels of CMOS devices must be fixed high or low by using a pull-up or pull-down circuitry. Each unused pin should be connected to VDD or GND with a resistor, if it is considered to have a possibility of being an output pin. All handling related to the unused pins must be judged device by device and related specifications governing the devices.

#### 3 STATUS BEFORE INITIALIZATION OF MOS DEVICES

Note:

Power-on does not necessarily define initial status of MOS device. Production process of MOS does not define the initial operation status of the device. Immediately after the power source is turned ON, the devices with reset function have not yet been initialized. Hence, power-on does not guarantee out-pin levels, I/O settings or contents of registers. Device is not initialized until the reset signal is received. Reset operation must be executed immediately after power-on for devices having reset function.

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